

	Hits	Search Text	DBs
32	141	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial) same (alignment or interferometer)) and ((second or double or multiple or subsequent\$4 or sequent\$4) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module)) and ((diffract\$4 or holographic or interference or (dual\$4 near6 beam)) same (expos\$4 or illuminat\$4 or pattern)) and (line\$3width or lines or (line near9 space)) and ((expos\$4 or irradiat\$4 or illuminat\$4) near30 ((unexpos\$4 or masked or shielded) near12 (portion or area or line or pattern)))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text	DBs
33	0	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial) same (alignment or interferometer)) and ((second or double or multiple or subsequent\$4 or sequent\$4) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module)) and ((diffract\$4 or holographic or interference or (dual\$4 near6 beam)) same (expos\$4 or illuminat\$4 or pattern)) and (line\$3width or lines or (line near9 space)) and ((expos\$4 or irradiat\$4 or illuminat\$4) near30 ((unexpos\$4 or masked or shielded) near12 (portion or area or line or pattern)) near29 linewidth)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text	DBs
34	0	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial) same (alignment or interferometer)) and ((second or double or multiple or subsequent\$4 or sequent\$4) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module)) and ((diffract\$4 or holographic or interference or (dual\$4 near6 beam)) same (expos\$4 or illuminat\$4 or pattern)) and (line\$3width or lines or (line near9 space)) and (((expos\$4 or irradiat\$4 or illuminat\$4) near30 ((unexpos\$4 or masked or shielded) near12 (portion or area or line or pattern))) same linewidth)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
35	10	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial)) and ((second or double or multiple) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module)) and ((diffract\$4 or holographic or interference) same (expos\$4 or illuminat\$4 or pattern) same (line\$3width or lines)) and (expos\$4 same (unexpos\$4 or line) same pattern\$4 same align\$5) and (first near9 linewidth) and ((second or subsequent or sequential\$4) near16 linewidth)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text	DBs
36	1	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial) same (alignment or interferometer)) and ((second or double or multiple or subsequent\$4 or sequent\$4) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module)) and ((diffract\$4 or holographic or interference or (dual\$4 near6 beam)) same (expos\$4 or illuminat\$4 or pattern)) and (line\$3width or lines or (line near9 space)) and ((expos\$4 or irradiat\$4 or illuminat\$4) near30 ((unexpos\$4 or masked or shielded) near12 (portion or area or line or pattern))) and (first near20 linewidth) and (second near20 linewidth)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text	DBs
37	81	((system or apparatus or module) same (expos\$4 or irradiat\$4 or illuminat\$4) same (first or initial) same (alignment or interferometer)) and ((second or double or multiple or subsequent\$4 or sequent\$4) same (expos\$4 or illuminat\$4 or irradiat\$4) same (apparatus or system or module) same align\$4) and ((diffract\$4 or holographic or interference or (dual\$4 near6 beam)) same (expos\$4 or illuminat\$4 or pattern)) and ((line\$3width or lines or (line near9 space)) same (first or second)) and ((expos\$4 or irradiat\$4 or illuminat\$4) near30 ((unexpos\$4 or masked or shielded) near12 (portion or area or line)))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB